

# Search Notes



Application/Control No.

10/782,676

Examiner

Hiep T. Nguyen

Applicant(s)/Patent under  
Reexamination

CHIANG ET AL.

Art Unit

2187

## SEARCHED

Class	Subclass	Date	Examiner
711	202	Text search using EAST 2/21/06 HN	
	203		
	206		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST search lis. is attached	2/21/06	HN
NPL search using terms similar to EAST search		
Inventorship search	✓	✓